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<h2 style="margin: 0;">Notice of References Cited</h2>	Application/Control No. <div style="text-align: center; font-weight: bold;">10/066,760</div>		Applicant(s)/Patent Under Reexam <div style="text-align: center; font-weight: bold;">Iihoshi et al.</div>	
	Examiner <div style="text-align: center; font-weight: bold;">Tu M. Nguyen</div>		Art Unit <div style="text-align: center; font-weight: bold;">3748</div>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
	A	5,956,942	9/1999	Sebastiano et al.	60	284
	B					
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
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**FOREIGN PATENT DOCUMENTS**

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	N						
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**NON-PATENT DOCUMENTS**

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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